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Finite element analysis of the piezoelectric vibrations of quartz plate resonators with higher-order plate theory

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Abstract

A finite element formulation of the piezoelectric vibrations of quartz resonators based on Mindlin plate theory is derived. The higher-order plate theory is employed for the development of a collection of successively higher-order plate elements which can be effective for a broad frequency range including the fundamental and overtone modes of thickness-shear vibrations. The presence of electrodes is also considered for their mechanical effects.

The mechanical displacements and electric potential are combined into a generalized displacement field, and the subsequent derivations are carried out with all the generalized equations. Through the standard finite element procedure, the vibration frequency, the vibration mode shapes and the electric potential distribution are obtained. The frequency spectra are compared with some well-known experimental results with good agreement.

Our previous experience with finite element analysis of high-frequency quartz plate vibrations leads us to believe that memory and computing time will always remain as key issues despite the advances in computers. Hence, the use of sparse matrix techniques, efficient eigenvalue solvers, and other reduction procedures are explored. © 1999 Elsevier Science Ltd. All rights reserved.

1. Introduction

The application of finite element method in the analysis of vibrations of quartz crystal plate resonators has been studied by many authors in the last decades, and practical results have been obtained gradually through these efforts. Given the fact that the problem is greatly complicated by the higher vibration frequency, which means fundamental thickness-shear frequency here, in

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comparison with the conventional structural vibration problem in flexural modes and limited interest in the finite element analysis, only a few of the programs developed so far have found applications in the design process and analysis of new products, but further interest have been inspired by the increasingly active research projects and promising results which could have a big impact on the design of quartz crystal resonators in the future.

Even though the analytical approach of plate resonators has been restricted to the two-dimensional plate equations with straight-crested wave solutions (see e.g. Mindlin and Gazis, 1962; Lee and Wang, 1994; Wang and Momosaki, 1997) for obvious reasons, the finite element formulations have been drawn from three-dimensional piezoelectricity equations and various two-dimensional plate theories. Lee and Tang (1986) implemented the finite element analysis of the first-order Mindlin plate equations for the stress sensitivity and vibration analysis of circular crystal resonators. With the three-dimensional incremental theory for frequency-temperature relations of quartz crystals, Yong (1987) studied the frequency-temperature behavior of crystal bar, plate, and tuning-fork type resonators. Later, the two-dimensional incremental theory were implemented for the finite element analysis of plate resonators (Yong, 1988). Canfield et al. (1991, 1992) studied the same problem with the implementation of the three-dimensional piezoelectricity with thermal effect considerations. Mindlin first-order plate theory was implemented for the mechanical vibrations of crystal resonators by Yong et al. (1991, 1992) and for the frequency shift due to temperature variations by Antonova and Silvester (1994). In the finite element implementation of Lee plate theory, Yong and Zhang (1993, 1994) developed a perturbation technique to consider the piezoelectric effect in the modeling of quartz plate resonators. The same finite element program was also used for straight-crested wave solutions of thin film piezoelectric resonators by Zhang and Yong (1995). To reduce the number of equations in the two-dimensional finite element implementation of the plate theory, a creative one-dimensional finite element formulation has been crafted by Sekimoto and Watanabe (1990). Noting that the higher-order plate theory may actually reduce the number of equations in the finite element implementation in comparison with threedimensional approach (Zhang and Yong, 1995), which is particularly important in the high frequency vibration analysis, Yong et al. (1996) implemented Mindlin higher-order plate theory for quartz resonator analysis with finite strip formulation. Of course, the systematic study of the accuracy of plate theories by Yong et al. (1996) is the basis of the applications of higher-order theories. Mindlin third-order plate theory is also used for the finite element study of the frequencytemperature behavior of crystal resonators by Yong (1996). Lerch (1990) and Lerch and Bauereschmidt (1996) extended the application of the piezoelectric three- and two-dimensional finite element program into the analysis of quartz resonators. By approximating the electric field, Stewart and Stevens (1997) employed the three-dimensional finite element method for the crystal resonator analysis. The computing techniques and resources available for finite element analysis, including efficient and reliable eigenvalue solvers, sparse matrix handling techniques, and parallel computing have been explored and utilized (Jones and Plassmann, 1992; Yong and Cho, 1996). Applications of general purpose finite element software such as ANSYS have also been reported by several authors (see e.g. Momosaki and Kogure, 1982; Beeby and Tudor, 1995; Söderkvist, 1997; Gehin et al., 1997).

In this study, we start with Mindlin higher-order plate theory for piezoelectric crystal plates. In the finite element formulation, we define the components of the mechanical displacements and electric potential as the generalized displacement, and as a consequence the generalized stress and



Fig. 1. Plate coordinates and boundaries.

strain are also defined in a similar manner. Eventually, this results in a generalized implementation which is very close to the conventional one for mechanical vibration analysis except the mass terms corresponding to the electric potential are zeroes, which leads to a more sparser mass matrix. The sparse matrix handling techniques are employed in the assembling and solving of the eigenvalue problems. Finally, we compare the numerical results of the vibration spectrum of a crystal plate to the well-known experimental measurements by Koga (1963), and excellent agreement has been observed.

2. Fundamentals of mindlin plate theory

The fundamental equations of Mindlin higher-order piezoelectric plate theory (Mindlin, 1972, 1984) are based on the infinite power series expansion of the mechanical displacements and electric potential in thickness coordinate x_2 , as shown in Fig. 1, to

$$u_{j}(x_{1}, x_{2}, x_{3}, t) = \sum_{n=0}^{\infty} u_{j}^{(n)}(x_{1}, x_{3}, t)x_{2}^{n},$$

$$\phi(x_{1}, x_{2}, x_{3}, t) = \sum_{n=0}^{\infty} \phi^{(n)}(x_{1}, x_{3}, t)x_{2}^{n},$$
(1)

where $u_j^{(n)}$ and $\phi^{(n)}$ are *n*th-order two-dimensional components of the displacements and potential. The strain–mechanical displacement and electric field–electric potential relations of the higherorder plate theory can be written as

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$$S_{ij}^{(n)} = \frac{1}{2} [u_{i,j}^{(n)} + u_{j,i}^{(n)} + (n+1)(\delta_{i2}u_{j}^{(n+1)} + \delta_{j2}u_{i}^{(n+1)})],$$

$$E_{i}^{(n)} = -\phi_{,i}^{(n)} - (n+1)\delta_{i2}\phi^{(n+1)},$$
(2)

where δ_{i2} is the Kronecker delta.

The two-dimensional linear piezoelectric constitutive equations are

$$T_{ij}^{(n)} = \sum_{m=0}^{\infty} B_{mn} (c_{ijkl} S_{kl}^{(m)} - e_{kij} E_k^{(m)}),$$

$$D_i^{(n)} = \sum_{m=0}^{\infty} B_{mn} (e_{ijk} S_{jk}^{(m)} + \varepsilon_{ij} E_j^{(m)}),$$
(3)

where $T_{ij}^{(n)}$, $D_i^{(n)}$, $S_{kl}^{(m)}$, $E_k^{(m)}$, c_{ijkl} , e_{kij} , and ε_{ij} are stress components, electric displacement components, strain components, electric field components, elastic constants, piezoelectric constants, and dielectric constants, respectively. The integral constant B_{mn} is

$$B_{mn} = \begin{cases} \frac{2b^{m+n+1}}{m+n+1}, & m+n = \text{even}, \\ 0, & m+n = \text{odd}. \end{cases}$$
(4)

The two-dimensional stress equations of motion and electrostatics derived from the threedimensional ones are

$$T_{ij,i}^{(n)} - nT_{2j}^{(n-1)} + B_{nn}T_{j}^{(n)} = \rho \sum_{m=0} B_{mn}\ddot{u}_{j}^{(m)},$$

$$D_{i,i}^{(n)} - nD_{2}^{(n-1)} + B_{nn}D^{(n)} = 0,$$
 (5)

with

$$T_{j}^{(n)} = \frac{1}{B_{nn}} b^{n} [T_{2j}(b) - (-1)^{n} T_{2j}(-b)],$$

$$D^{(n)} = \frac{1}{B_{nn}} b^{n} [D_{2}(b) - (-1)^{n} D_{2}(-b)],$$
(6)

where ρ , $T_j^{(n)}$, $D^{(n)}$, $T_{2j}(b)$, $T_{2j}(-b)$, $D_2(b)$, and $D_2(-b)$ are the density of the crystal, face traction difference, face charge difference, upper face traction, lower face traction, upper face charge, and lower face charge, respectively.

The boundary conditions for the two-dimensional equations can be directly derived from the three-dimensional ones with the known expansions of the displacements and potential in power series. By defining the *n*th-order surface traction and charge as

$$t_{j}^{(n)} = \frac{1}{B_{nn}} \int_{-b}^{b} t_{j} x_{2}^{n} \,\mathrm{d}x_{2}, \quad \sigma^{(n)} = \frac{1}{B_{nn}} \int_{-b}^{b} \sigma x_{2}^{n} \,\mathrm{d}x_{2}, \tag{7}$$

where t_j and σ are prescribed surface traction and charge, we have the following natural boundary conditions

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$$t_{j} = T_{2j}, \quad \sigma = D_{2} \quad \text{on } A, \quad j = 1, 2, 3,$$

$$t_{j}^{(n)} = n_{a} T_{aj}^{(n)}, \quad \sigma^{(n)} = n_{a} D_{a}^{(n)} \quad \text{on } C, \quad a = 1, 3,$$
(8)

or their alternatives

$$u_j = \bar{u}_j, \quad \phi = \bar{\phi} \quad \text{on } A,$$

$$u_j^{(n)} = \bar{u}_j^{(n)}, \quad \phi^{(n)} = \bar{\phi}^{(n)} \quad \text{on } C,$$
(9)

where the barred quantities represent the prescribed boundary values on A and C. It should be noted that the boundary conditions in eqn (8)₁ are already incorporated into eqn (5) by specifying $T_i^{(n)}$ and $D^{(n)}$ according to eqn (6).

These equations have been extensively used for the straight-crested wave solutions of crystal resonators in conjunction with some approximate techniques such as truncation and one-dimensional approximation (see e.g. Lee and Wang, 1994; Wang and Momosaki, 1997). By formulating and implementing the higher-order equations in a systematic manner, we hope that a finite element program can be developed for the vibration analysis of crystal resonators at not only the fundamental thickness-shear but also the higher-order overtone frequencies.

3. Modifications of the plate equations

The higher-order plate equations given in the previous section are complete for the vibration analysis of quartz plates, and their application is straightforward. However, given the fact that in piezoelectric resonators the crystal plates are always electroded, modifications are needed for both the mechanical and piezoelectric vibration analyses. Furthermore, we need a proper procedure to reduce the infinite system and correct and compensate the finite set of equations for practical and accurate solutions. These modifications, as have been made before by many authors, include the consideration of the mechanical effects of the platings of the electrodes, the corrections of the truncated plate equations, and the truncation procedure itself. These procedures have been developed and employed for many years, and they can be treated as the standard procedures for the applications of higher-order plate theories. Through the modifications we present below, the plate theory introduced before will be tailored for the crystal resonator vibration analysis at the fundamental thickness-shear and overtone frequencies.

3.1. The mechanical effects of platings

The thin layers of metal platings on crystal plates for thickness excitation purpose are usually treated as mass loading on the crystal plates, and it has been studied by Mindlin (1963), Tiersten (1969) and Lee et al. (1987).

We assume the thickness of the platings on both sides of the crystal are identical and denoted them as 2b', and the density of the platings is ρ' . The tractions on the faces of the plated crystal are

$$T_{2j}(b) = T_{2j}(B) - 2b'\rho' \ddot{u}_j(b),$$

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$$T_{2j}(-b) = T_{2j}(-B) + 2b'\rho'\ddot{u}_j(-b),$$
(10)

where B = b + 2b', and $T_{2i}(B)$ and $T_{2i}(-B)$ are the face tractions on the platings.

By substituting eqn (10) into eqn $(6)_1$, the difference of the crystal face tractions will be

$$T_{j}^{(n)} = \frac{1}{B_{nn}} [b^{n} T_{2j}(b) - (-b)^{n} T_{2j}(-b)]$$

= $\mathcal{F}_{j}^{(n)} - \frac{b^{n}}{B_{nn}} 2b' \rho' [\ddot{u}_{j}(b) + (-1)^{n} \ddot{u}_{j}(-b)],$ (11)

where $\mathscr{T}_{j}^{(n)}$ is the difference of the face tractions of the platings. In each mode for long wavelengths, we have

$$u_j(b) = \sum_{n=0}^{\infty} b^n u_j^{(n)}, \quad u_j(-b) = \sum_{n=0}^{\infty} (-b)^n u_j^{(n)}, \tag{12}$$

hence eqn (11) is further simplified to

$$B_{nn}T_{j}^{(n)} = B_{nn}\mathcal{T}_{j}^{(n)} - 2b'\rho'2b^{2n}\ddot{u}_{j}^{(n)}$$

= $B_{nn}\mathcal{T}_{j}^{(n)} - \rho \sum_{m=0} (m+n+1)RB_{nn}\ddot{u}_{j}^{(n)},$ (13)

where

$$R = \frac{2b'\rho'}{b\rho},\tag{14}$$

is the mass ratio of the electrodes to the crystal.

Now the stress equations of motion in eqn (5) with platings will be modified to

$$T_{ij,i}^{(n)} - nT_{2j}^{(n-1)} + B_{nn}\mathcal{F}_{j}^{(n)} = \rho \sum_{m=0} B_{mn} [1 + (m+n+1)R] \ddot{u}_{j}^{(m)}.$$
(15)

The mechanical effects in eqn (15) are consistent with similar equations by others (Mindlin, 1963; Tiersten, 1965).

3.2. Truncations of the equations

The two-dimensional infinite system has to be truncated to a finite set for their solutions, and a standard truncation procedure proposed by Mindlin (1955, 1972, 1984) has been widely employed (Lee and Wang, 1994). In this study we demonstrate the procedure for the truncation of the thirdorder theory of AT-cut quartz plates by setting

$$u_{1}^{(n)} = u_{3}^{(n)} = \phi^{(n)} = T_{p}^{(n)} = D_{i}^{(n)} = 0 \quad \text{for } n > 3,$$

$$T_{2}^{(3)} = 0, \quad u_{2}^{(4)} \neq 0, \quad \dot{u}_{2}^{(4)} = 0, \quad u_{2}^{(n)} = 0 \quad \text{for } n > 4,$$

$$p = 1, 2, 3, 4, 5, 6, \quad i = 1, 2, 3,$$
(16)

and from eqn $(3)_1$ we have

$$c_{22}4u_{2}^{(4)} = -\frac{7}{5b^{2}} [c_{21}u_{1,1}^{(1)} + c_{22}2u_{2}^{(2)} + c_{23}u_{3,3}^{(1)} + c_{24}(u_{2,3}^{(1)} + 2u_{3}^{(2)})] + c_{21}u_{1,1}^{(3)} + c_{23}u_{3,3}^{(3)} + c_{24}u_{2,3}^{(3)} + \frac{7}{5b^{2}}(e_{12}E_{1}^{(1)} + e_{22}E_{2}^{(1)} + e_{32}E_{3}^{(1)}) + e_{12}E_{1}^{(3)} + e_{22}E_{2}^{(3)} + e_{32}E_{3}^{(3)}.$$
 (17)

With the given $u_2^{(4)}$ in eqn (17), we can update all the equations containing $S_2^{(3)}$, which are stress component $T_p^{(1)}$ and $T_p^{(3)}$ (p = 1, 2, 3, 4, 5, 6) and electric displacement component $D_i^{(1)}$ and $D_i^{(3)}$ (i = 1, 2, 3), to

$$T_{p}^{(1)} = B_{11}\tilde{c}_{pq}S_{q}^{(1)} + B_{31}\bar{c}_{pq}S_{q}^{(3)} - B_{11}\tilde{e}_{kp}E_{k}^{(1)} - B_{31}\bar{e}_{kp}E_{k}^{(3)},$$

$$T_{p}^{(3)} = B_{13}\bar{c}_{pq}S_{q}^{(1)} + B_{33}\bar{c}_{pq}S_{q}^{(3)} - B_{13}\bar{e}_{kp}E_{k}^{(1)} - B_{33}\bar{e}_{kp}E_{k}^{(3)},$$

$$D_{i}^{(1)} = B_{11}\tilde{e}_{iq}S_{q}^{(1)} + B_{31}\bar{e}_{iq}S_{q}^{(3)} + B_{11}\tilde{e}_{ik}E_{k}^{(1)} + B_{31}\bar{e}_{ik}E_{k}^{(3)},$$

$$D_{i}^{(3)} = B_{13}\tilde{e}_{iq}S_{q}^{(1)} + B_{33}\bar{e}_{iq}S_{q}^{(3)} + B_{13}\tilde{e}_{ik}E_{k}^{(1)} + B_{33}\bar{e}_{ik}E_{k}^{(3)},$$
(18)

with

$$\bar{c}_{pq} = c_{pq} - \frac{c_{p2}c_{2q}}{c_{22}}, \quad \tilde{c}_{pq} = c_{pq} - \frac{21}{25}\frac{c_{p2}c_{2q}}{c_{22}}, \\
\bar{e}_{kp} = c_{kp} - \frac{c_{p2}e_{k2}}{c_{22}}, \quad \tilde{e}_{kp} = c_{kp} - \frac{21}{25}\frac{c_{p2}e_{k2}}{c_{22}}, \\
\bar{e}_{ik} = \bar{e}_{ik} + \frac{e_{i2}e_{k2}}{c_{22}}, \quad \tilde{e}_{ik} = \bar{e}_{ik} + \frac{21}{25}\frac{e_{i2}e_{k2}}{c_{22}}, \\
p, q = 1, 2, 3, 4, 5, 6, \quad i, k = 1, 2, 3.$$
(19)

Truncations for higher-order equations and other cuts can be carried out in a similar fashion. In the finite element implementation, we have truncated the equations upto the fifth-order. It has also been observed from our computation that the truncations and the resulted modifications to the material constants have significant effect on certain branches of the frequency spectra.

3.3. Correction factors

The truncation of the first-order equations requires correction factors to warrant accurate results, and many correction factors have been suggested (see e.g. Mindlin, 1955, 1963, 1972; Tiersten, 1969) with various considerations including the presence of electrodes. In this study, the correction factors proposed by Mindlin (1955) is used as

$$\bar{c}_{pq} = \kappa_p \kappa_q c_{pq}, \quad \bar{e}_{ip} = \kappa_p e_{ip}, \quad \kappa_p = \begin{cases} \frac{\pi^2}{12}, & p, q = 2, 4, 6, \\ 1, & p, q = 1, 3, 5. \end{cases}$$
(20)

These truncated and corrected equations with plating considerations will be the plate equations for finite element implementation. In the computer program, the plate theory upto the fifth-order

is implemented so the computation can be made in a wide frequency range. The selection of the order of the plate theory for the computation has been discussed by Yong et al. (1995), but we also find that the aspect ratios and the frequency are the important factors.

4. Variational principles

The two-dimensional variational equations of higher-order plate theory, which will be the basis of the finite element formulation, for mechanical vibrations can be given as (see e.g. Mindlin, 1955, 1972, 1984; Tiersten, 1969)

$$\sum_{n} \int_{A} \left(T_{ij,i}^{(n)} - n T_{2j}^{(n-1)} + B_{nn} T_{j}^{(n)} - \rho \sum_{m=0} B_{mn} \ddot{u}_{j}^{(m)} \right) \delta u_{j}^{(n)} \, \mathrm{d}A = 0.$$
⁽²¹⁾

By applying the divergence theorem, we have

$$\int_{A} T_{ij,i}^{(n)} \delta u_{j}^{(n)} \, \mathrm{d}A = \int_{A} \left[(T_{ij}^{(n)} \delta u_{j}^{(n)})_{,i} - T_{ij}^{(n)} \delta u_{j,i}^{(n)} \right] \mathrm{d}A$$
$$= \int_{C} f_{j}^{(n)} \delta u_{j}^{(n)} \, \mathrm{d}S - \int_{A} T_{ij}^{(n)} \delta u_{j,i}^{(n)} \, \mathrm{d}A,$$
(22)

where n_i is the outward surface normal of the boundary, and the surface traction $f_i^{(n)}$ is defined as

$$f_{i}^{(n)} = n_i T_{ij}^{(n)}.$$
(23)

By definition we have

$$\sum_{n} (T_{ij}^{(n)} \delta u_{j,i}^{(n)} + n T_{2j}^{(n-1)} \delta u_{j}^{(n)}) = \sum_{n} T_{ij}^{(n)} \delta S_{ij}^{(n)}.$$
(24)

The substitution of eqns (22) and (24) into eqn (21) yields the variational equations of mechanical vibrations as

$$\sum_{n} \int_{A} \left(T_{ij}^{(n)} \delta S_{ij}^{(n)} + \rho \sum_{m=0} B_{mn} \ddot{u}_{j}^{(m)} \delta u_{j}^{(n)} \right) \mathrm{d}A = \sum_{n} \left(\int_{C} f_{j}^{(n)} \delta u_{j}^{(n)} \, \mathrm{d}S + \int_{A} F_{j}^{(n)} \delta u_{j}^{(n)} \, \mathrm{d}A \right), \tag{25}$$

where

$$F_{j}^{(n)} = B_{nn}T_{j}^{(n)}.$$
(26)

In a similar fashion, we have variational equations of electrostatics as

$$\sum_{n} \int_{A} D_{i}^{(n)} \delta E_{i}^{(n)} \, \mathrm{d}A = -\sum_{n} \left(\int_{C} q^{(n)} \delta \phi^{(n)} \, \mathrm{d}S + \int_{A} Q^{(n)} \delta \phi^{(n)} \, \mathrm{d}A \right), \tag{27}$$

and the surface charges and face charges are defined as

$$q^{(n)} = n_i D_i^{(n)}, \quad Q^{(n)} = B_{nn} D^{(n)}.$$
 (28)

For a piezoelectric solid we have the virtual electric enthalpy density definition (Mindlin, 1972)

$$\delta W = T_{ij}^{(n)} \delta S_{ij}^{(n)} - D_i^{(n)} \delta E_i^{(n)}, \tag{29}$$

thus the previous variational eqns (25) and (27) can be combined into

$$\sum_{n} \int_{A} \left[(T_{ij}^{(n)} \delta S_{ij}^{(n)} - D_{i}^{(n)} \delta E_{i}^{(n)}) \, \mathrm{d}A + \rho \sum_{m=0} B_{mn} \ddot{u}_{j}^{(m)} \delta u_{j}^{(n)} \, \mathrm{d}A \right] = \sum_{n} \int_{C} (f_{j}^{(n)} \delta u_{j}^{(n)} + q^{(n)} \delta \phi^{(n)}) \, \mathrm{d}S$$
$$+ \sum_{n} \int_{A} (F_{j}^{(n)} \delta u_{j}^{(n)} + Q^{(n)} \delta \phi^{(n)}) \, \mathrm{d}A. \quad (30)$$

Now we can use the variational eqn (30) for the finite element formulation of the higher-order plate theory. Ostensibly, the combination of the two variational equations, as we shall show next, is intended to aid the generalized formulation of the piezoelectric plate vibration problem.

5. Generalized finite element formulation

Traditionally, piezoelectric problems have been formulated by separating the mechanical variables, which are displacements, and electric variables, which are electric potentials in most cases, in the formation of the linear equation systems (see e.g. Allik and Hughes, 1970; Lerch, 1990; Yong and Zhang, 1993, 1994, 1995). By taking this approach, the two sets of equations will be eventually reduced to the mechanical vibration problem through the elimination of the electric one, and many techniques have been proposed for the condensation of the stiffness matrix (Allik and Hughes, 1970; Lerch, 1990), including a perturbation technique (Yong and Zhang, 1993, 1994, 1995). However, it has also been noticed lately that the generalized approach, which means the mechanical displacement and electric potentials will be combined to form a generalized displacement field, may also be advantageous since the costly condensation of the stiffness matrix can be avoided to speed up the eigenvalue computation (Yong and Cho, 1996).

In this paper, the higher-order piezoelectric plate theory is presented in a generalized matrix form to facilitate the finite element implementation. The representative matrices are illustrated, again, with the third-order plate theory.

We start with the generalized *n*th-order displacement field $u_i^{(n)}$ (n = 0, 1, 2, 3)

$$\mathbf{u}^{(n)} = \{u_1^{(n)}, u_2^{(n)}, u_3^{(n)}, \phi^{(n)}\}_{4 \times 1},\tag{31}$$

and accordingly we have the generalized displacement vector from the third-order plate theory as

$$\mathbf{u} = \{\mathbf{u}^{(0)}, \mathbf{u}^{(1)}, \mathbf{u}^{(2)}, \mathbf{u}^{(3)}\}_{16 \times 1}.$$
(32)

We further define the generalized *n*th-order strain and stress vectors as

$$\mathbf{S}^{(n)} = \{S_1^{(n)}, S_2^{(n)}, S_3^{(n)}, S_4^{(n)}, S_5^{(n)}, S_6^{(n)}, E_1^{(n)}, E_2^{(n)}, E_3^{(n)}\}_{9 \times 1}, \mathbf{T}^{(n)} = \{T_1^{(n)}, T_2^{(n)}, T_3^{(n)}, T_4^{(n)}, T_5^{(n)}, T_6^{(n)}, D_1^{(n)}, D_2^{(n)}, D_3^{(n)}\}_{9 \times 1}.$$
(33)

From the generalized strain–displacement relations in eqn (2), by rearranging the terms, we can write

$$\mathbf{S}^{(n)} = \hat{\sigma}_u \mathbf{u}^{(n)} + \hat{\sigma}_u^{(n+1)} \mathbf{u}^{(n+1)}, \tag{34}$$

where the two strain operators are defined as

$$\partial_{u}^{(n+1)} = (n+1) \begin{bmatrix} \frac{\partial}{\partial x_{1}} & 0 & 0 & 0 \\ 0 & 0 & \frac{\partial}{\partial x_{3}} & 0 \\ 0 & \frac{\partial}{\partial x_{3}} & 0 & 0 \\ \frac{\partial}{\partial x_{3}} & 0 & \frac{\partial}{\partial x_{1}} & 0 \\ 0 & \frac{\partial}{\partial x_{1}} & 0 & 0 \\ 0 & 0 & 0 & -\frac{\partial}{\partial x_{1}} \\ 0 & 0 & 0 & 0 \\ 0 & 0 & 0 & -\frac{\partial}{\partial x_{3}} \end{bmatrix}_{9 \times 4}$$

(35)

and finally, eqn (34), we define the generalized strain vector, with

$$\mathbf{S} = \begin{cases} \mathbf{S}^{(0)} \\ \mathbf{S}^{(1)} \\ \mathbf{S}^{(2)} \\ \mathbf{S}^{(3)} \end{cases} = \partial_{S} \mathbf{u}$$

$$= \begin{bmatrix} \partial_{u} & \partial_{u}^{(1)} & \mathbf{0} & \mathbf{0} \\ \mathbf{0} & \partial_{u} & \partial_{u}^{(2)} & \mathbf{0} \\ \mathbf{0} & \mathbf{0} & \partial_{u} & \partial_{u}^{(3)} \\ \mathbf{0} & \mathbf{0} & \mathbf{0} & \partial_{u} \end{bmatrix}_{36 \times 16} \begin{bmatrix} \mathbf{u}^{(0)} \\ \mathbf{u}^{(1)} \\ \mathbf{u}^{(2)} \\ \mathbf{u}^{(3)} \end{bmatrix}_{16 \times 1}.$$
(36)

The linear piezoelectric constitutive relations given in eqn (3) can also be generalized and written in matrix form as

$$\mathbf{T} = \mathbf{CS},\tag{37}$$

where

.

$$\mathbf{C} = \begin{bmatrix} B_{00}\bar{\mathbf{C}} & \mathbf{0} & B_{02}\bar{\mathbf{C}} & \mathbf{0} \\ \mathbf{0} & B_{11}\bar{\mathbf{C}} & \mathbf{0} & B_{13}\bar{\mathbf{C}} \\ B_{20}\bar{\mathbf{C}} & \mathbf{0} & B_{22}\bar{\mathbf{C}} & \mathbf{0} \\ \mathbf{0} & B_{31}\bar{\mathbf{C}} & \mathbf{0} & B_{33}\bar{\mathbf{C}} \end{bmatrix}_{36\times 36},$$

$$\bar{\mathbf{C}} = \begin{bmatrix} \mathbf{c} & -\mathbf{e}^T \\ \mathbf{e} & \varepsilon \end{bmatrix}_{9\times 9}.$$
(38)

It is interesting to note that the generalized material constant matrix is no longer symmetric.

In matrix form, the variational eqn (30) can be written as

$$\int_{A} (\delta \mathbf{S}^{T} \mathbf{c} \mathbf{S} - \delta \mathbf{S}^{T} \mathbf{e}^{T} \mathbf{E} - \delta \mathbf{E}^{T} \mathbf{e} \mathbf{S} - \delta \mathbf{E}^{T} \mathbf{e} \mathbf{E} + \rho \delta \mathbf{u}^{T} \mathbf{m} \mathbf{\ddot{u}}) \, \mathrm{d}A$$
$$= \int_{C} (\delta \mathbf{u}^{T} \mathbf{f} + \delta \phi^{T} \mathbf{q}) \, \mathrm{d}S + \int_{A} (\delta \mathbf{u}^{T} \mathbf{F} + \delta \phi^{T} \mathbf{Q}) \, \mathrm{d}A, \quad (39)$$

where \mathbf{m} , \mathbf{f} , \mathbf{q} , \mathbf{F} , and \mathbf{Q} are the mass matrix, the surface traction vector, surface charge vector, face traction vector, and face charge vector, respectively, are to be combined into the generalized surface traction and face traction from now on.

In generalized notations we can write eqn (39) as

$$\int_{A} \delta \mathbf{S}^{T} \mathbf{D} \mathbf{S} \, \mathrm{d}A + \int_{A} \rho \, \delta \mathbf{u}^{T} \mathbf{m} \ddot{\mathbf{u}} \, \mathrm{d}A = \int_{C} \delta \mathbf{u}^{T} \mathbf{f} \, \mathrm{d}S + \int_{A} \delta \mathbf{u}^{T} \mathbf{F} \, \mathrm{d}A, \tag{40}$$

where

$$\mathbf{D} = \begin{bmatrix} B_{00}\mathbf{\bar{D}} & \mathbf{0} & B_{02}\mathbf{\bar{D}} & \mathbf{0} \\ \mathbf{0} & B_{11}\mathbf{\bar{D}} & \mathbf{0} & B_{13}\mathbf{\bar{D}} \\ B_{20}\mathbf{\bar{D}} & \mathbf{0} & B_{22}\mathbf{\bar{D}} & \mathbf{0} \\ \mathbf{0} & B_{31}\mathbf{\bar{D}} & \mathbf{0} & B_{33}\mathbf{\bar{D}} \end{bmatrix}_{36 \times 36},$$

$$\begin{split} \mathbf{\bar{D}} &= \begin{bmatrix} \mathbf{c} & -\mathbf{e}^{T} \\ -\mathbf{e} & -\varepsilon \end{bmatrix}_{9 \times 9}, \\ \mathbf{m} &= \begin{bmatrix} \mathbf{m}_{0}^{(0)} & \mathbf{0} & \mathbf{m}_{0}^{(2)} & \mathbf{0} \\ \mathbf{0} & \mathbf{m}_{1}^{(1)} & \mathbf{0} & \mathbf{m}_{1}^{(3)} \\ \mathbf{m}_{2}^{(0)} & \mathbf{0} & \mathbf{m}_{2}^{(2)} & \mathbf{0} \\ \mathbf{0} & \mathbf{m}_{3}^{(1)} & \mathbf{0} & \mathbf{m}_{3}^{(3)} \end{bmatrix}_{16 \times 16}, \\ \mathbf{m}_{m}^{(n)} &= \rho B_{mn} [1 + (m+n+1)R] \begin{bmatrix} 1 & \mathbf{0} & \mathbf{0} & \mathbf{0} \\ \mathbf{0} & 1 & \mathbf{0} & \mathbf{0} \\ \mathbf{0} & \mathbf{0} & \mathbf{1} & \mathbf{0} \\ \mathbf{0} & \mathbf{0} & \mathbf{0} & \mathbf{0} \end{bmatrix}_{4 \times 4}. \end{split}$$
(41)

It should be emphasized that the mass matrix has zero terms corresponding to the electric potentials.

Following the conventional discretization procedure, we start the finite element implementation with

$$\mathbf{u} = \begin{bmatrix} \mathbf{u}^{(0)} \\ \mathbf{u}^{(1)} \\ \mathbf{u}^{(2)} \\ \mathbf{u}^{(3)} \end{bmatrix}_{16 \times 1} = [\mathbf{\hat{N}}_1 \mathbf{\hat{N}}_2, \dots, \mathbf{\hat{N}}_l]_{16 \times 16l} \begin{bmatrix} \mathbf{U}_1 \\ \mathbf{U}_2 \\ \vdots \\ \mathbf{U}_l \end{bmatrix}_{16l \times 1} = \mathbf{NU},$$
$$\mathbf{\hat{N}}_i = N_i \mathbf{I}_{16 \times 16}, \quad \mathbf{S} = \partial_S \mathbf{NU} = \mathbf{BU},$$
$$\mathbf{B} = [\mathbf{B}_1 \mathbf{B}_2, \dots, \mathbf{B}_l], \quad i = 1, 2, \dots, l,$$
(42)

where l is the number of nodes of each element, **U** is the discretized displacement vector, N_i are the shape functions, **I** is the identity matrix, and the **B**_i matrix is given as

$$\mathbf{B}_{i} = \begin{bmatrix} \partial_{u}N_{i} & \partial_{u}^{(1)}N_{i} & \mathbf{0} & \mathbf{0} \\ \mathbf{0} & \partial_{u}N_{i} & \partial_{u}^{(2)}N_{i} & \mathbf{0} \\ \mathbf{0} & \mathbf{0} & \partial_{u}N_{i} & \partial_{u}^{(3)}N_{i} \\ \mathbf{0} & \mathbf{0} & \mathbf{0} & \partial_{u}N_{i} \end{bmatrix}_{36 \times 16}$$
(43)

The discretization of the variational eqn (40) gives

$$\delta \mathbf{U}^{T} \left(\int_{A} \mathbf{B}^{T} \mathbf{D} \mathbf{B} \, \mathrm{d} A \mathbf{U} + \int_{A} \mathbf{N}^{T} \mathbf{m} \mathbf{N} \, \mathrm{d} A \ddot{\mathbf{U}} - \int_{C} \mathbf{N}^{T} \mathbf{f} \, \mathrm{d} S - \int_{A} \mathbf{N}^{T} \mathbf{F} \, \mathrm{d} A \right) = 0, \tag{44}$$

and the discretized and generalized equations of motion in matrix form as

$$\mathbf{KU} + \mathbf{M\ddot{U}} = \mathbf{F}_C + \mathbf{F}_A,\tag{45}$$

where

$$\mathbf{K} = \int_{A} \mathbf{B}^{T} \mathbf{D} \mathbf{B} \, \mathrm{d} A, \quad \mathbf{M} = \int_{A} \mathbf{N}^{T} \mathbf{m} \mathbf{N} \, \mathrm{d} A,$$

$$\mathbf{F}_{C} = \int_{C} \mathbf{N}^{T} \mathbf{f} \, \mathrm{d} S, \quad \mathbf{F}_{A} = \int_{A} \mathbf{N}^{T} \mathbf{F} \, \mathrm{d} A,$$
(46)

are generalized stiffness matrix, mass matrix, surface traction vector, and face traction vector, respectively.

^

Now we have the conventional finite element equation given in eqn (45), which is the identical one we already know in structural mechanics problems, where the finite element method has been intensively studied for decades. By adopting this formulation, it is hoped that all the sophisticated techniques can be utilized.

For free vibrations, by setting the traction vectors to zero and assuming the solution is harmonic, we have the generalized vibration eigenvalue problem from eqn (45)

$$\mathbf{KU} - \omega^2 \mathbf{MU} = 0, \tag{47}$$

where ω is the vibration frequency. Usually we normalized the frequency by the fundamental thickness-shear frequency

$$\omega_0 = \frac{\pi}{2b} \sqrt{\frac{c_{66}}{\rho}}.$$
(48)

It is clear from the matrix equations that the mass matrix is no longer diagonal due to the coupling of modes, and the off-diagonal terms have to be included in the computations. A comparison with the conventional finite element analysis will tell that this will add further difficulty to the eigenvalue computation. The high vibration frequency will also require a finer mesh, which translates to a very large, usually several millions, linear equation system. For this reason, an efficient eigenvalue solver can handle sparse matrix computation, which is standard in most finite element analysis programs today, is essential to this program. Also it should be realized that we have a critical requirement for such eigenvalue solvers, namely they should be able to extract all the eigenvalues inside a given frequency interval, usually in the vicinity of the resonance vibration frequency. Eigenvalue solvers capable of this kind of computation are difficult to find, and extra efforts have to be made to modify the existing ones in public domains such as the Netlib, or locate available commercial codes.

As an example, we computed the frequency spectra of a crystal plate with third-order plate theory and four-node element to make comparisons with the experimental data by Koga (1963). It is found that the frequency spectra from pure mechanical vibrations agree well with the measurement in Fig. 2, and the frequency change due to piezoelectric effect is clearly displayed in Fig. 3. The frequency difference between mechanical and piezoelectric vibrations is shown in Fig. 4.

6. Conclusions

The higher-order Mindlin plate theory has been systematically modified for applications in the piezoelectric vibration analysis of crystal resonators for the resonance frequency spectrum. By



Fig. 2. Normalized frequency vs length to thickness ratio for a crystal plate with width to thickness ratio c/b = 16.3660. The computed frequency spectra from the mechanical vibrations (\bigcirc) is compared with the experimental data (dark square) from Koga (1963).

adopting a generalized approach, the modified plate theory is successfully implemented for the finite element solutions for the vibration problems which have been extensively studied but never been able to solve for the precise and accurate modeling of crystal resonators. From the comparisons of the numerical results of the mechanical and piezoelectric vibrations, we found that this generalized formulation is straightforward and effective for the piezoelectric plate vibration problems. The results also confirmed the long time view widely known to researchers that the piezoelectric effects on the free vibrations of the crystal plates can be neglected in the frequency spectrum analysis since the frequency shift is tiny and uniform. For practical purposes, the frequency spectrum from the mechanical vibrations will provide a valuable and precise pattern for better selection of plate geometry. We also found that we have produced the frequency spectra from both the mechanical and piezoelectric vibrations which match the experimental data well.

It is agreed that the modeling of piezoelectric devices with finite element method continues to be a challenge, partially due to the extremely high frequency, which requires the unusually larger number of equations, in comparison with conventional finite element analysis applications. This challenge spreads further to strict requirement for efficient mathematical subroutines essential to the analysis, namely the eigenvalue solvers and linear equation solvers. Fortunately, the mathematical community has been inspired and encouraged by these rigorous attempts, and tremendous progress



Fig. 3. Normalized frequency vs length to thickness ratio for a crystal plate with width to thickness ratio c/b = 16.3660. The computed frequency spectra from the piezoelectric vibrations (\triangle) is compared with the experimental data (dark square) from Koga (1963).

has been made for the efficient and fast solvers, while such efforts are continuing to meet the demands for even larger problems. Also the availability of powerful computers provides another opportunity, particularly with the proliferation of multiple processors systems which can be easily programmed to solve the larger number of equations from the problem.

On the piezoelectricity theory, tremendous efforts have been made to make the approximate theories to be able to solve the real problem easily and accurately. These efforts will also assist the better finite element implementation for less equations but accurate results. Particularly, the efforts in reducing the order of the plate theory and the elimination of the electric variable from the equations will have great impact on the computing aspect.

With the combination of the efforts in all directions, it is expected that we shall be able to provide efficient and accurate numerical solutions to assist the crystal resonator development.

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Fig. 4. Comparison of the computed normalized frequency vs length to thickness ratio from the piezoelectric vibrations (\triangle) and mechanical vibrations (\bigcirc) for a crystal plate with width to thickness ratio c/b = 16.3660.

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